

Notice of References Cited		Application/Control No. 10/623,645	Applicant(s)/Patent Under Reexamination WANG ET AL.	
		Examiner PETER L. CHENG	Art Unit 2625	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2002/0163490	11-2002	Nose, Takashi	345/89
*	B US-2003/0132907	07-2003	Lee et al.	345/98
*	C US-6,181,311	01-2001	Hashimoto, Seiji	345/98
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
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FOREIGN PATENT DOCUMENTS

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N					
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NON-PATENT DOCUMENTS

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